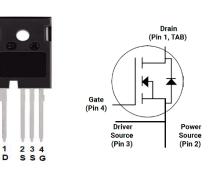


Product Summary

 $V_{DS} = 1200 V$ $I_D @ 25^{\circ}C = 64A$ $R_{DS(ON)} = 36m\Omega$





TO-247-4

Features

- High Blocking Voltage
- High Frequency Operation
- Low on-resistance
- · Fast intrinsic diode with low reverse recovery

Applications

- Motor Drives
- Solar / Wind Inverters
- EV Charging Station

Benefits

- Higher System Efficiency
- Parallel Device Convenience without thermal runaway
- High Temperature Application
- Hard Switching & Higher Reliability
- Easy to drive
- AC/DC converters
- DC/DC converters
- Uninterruptable power supplies

Maximum Ratings (Tc=25°C unless otherwise specified)

Parameter	Symbol	Test conditions	Value	Unit
Drain - Source Voltage	V _{DSmax}	V _{GS} =0V, I _D =100µA	1200	V
Gate - Source Voltage (dynamic)	V _{GSmax}	AC (f>1 Hz)	-10 / +25	V
Gate - Source Voltage (static)	V _{GSop}	static	-5 / +20	V
Continuous Drain Current	I _D	V _{GS} = 20V, T _C =25°C	64	Α
		V _{GS} = 20V, T _C =100°C	45	
Pulsed Drain Current	I _{D(pulse)}	T _c =25°C	112	A
Short Circuit Capability	t _{sc}	V _{DD} =800V, V _{GS} =20V	3	μS
Short Circuit Capability	I _{DS}	V _{DD} =800V, V _{GS} =20V	600	Α
Total power dissipation	PD	T _C =25°C	300	W
Operating Junction Temperature	TJ		-55 to 175	°C
Storage Temperature	T _{STG}		-55 to 175	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

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Parameter	Symbol	Test conditions	Min	Тур	Max	Unit
Drain-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0V, I_D = 100\mu A$	1200			V
Gate Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 10mA$	1.8	2.8	3.9	V
		$V_{DS} = V_{GS}, I_D = 10mA, T_J = 150^{\circ}C$		1.9		
		$V_{DS} = V_{GS}, I_D = 10mA, T_J = 175^{\circ}C$		1.8		V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 1200V, V _{GS} = 0V	0	5	100	μA
Gate-Source Leakage Current	I _{GSS}	$V_{GS} = 20V, V_{DS} = 0V$	0	10	200	nA
Gate-Source Leakage Current	I _{GSS}	$V_{GS} = -5V, V_{DS} = 0V$	-200	-10	0	nA
	R _{DS(on)}	$V_{GS} = 18V, I_D = 40 A$		41		
		V _{GS} = 18V, I _D = 40 A, T _J = 150°C		61		- mΩ
Drain-Source On-State		V _{GS} = 18V, I _D = 40 A, T _J = 175°C		68		
Resistance		$V_{GS} = 20V, I_D = 40 A$		36	50	
		V _{GS} = 20V, I _D = 40 A, T _J = 150°C		58		
		V _{GS} = 20V, I _D = 40 A, T _J = 175°C		65		
Transconductance	g _{fs}	$V_{DS} = 20V, I_{D} = 40 A,$		23		s
		V _{DS} = 20V, I _D = 40 A, T _J = 150°C		20		
		V _{DS} = 20V, I _D = 40 A, T _J = 175°C		20		
Input capacitance	C _{iss}			2980		
Output capacitance	C_{oss}	$V_{DS} = 1000V, V_{GS} = 0V$ f = 1MHz		143		pF
Reverse transfer capacitance	C _{rss}			15		
Coss Stored Energy	E _{oss}			92		μJ
Total gate charge	Q_{g}	1/2 = 8001/1/2 = 51/2001/2001/2001/2001/2001/2001/2001/20		148		
Gate-source charge	Q_gs	$V_{DS} = 800V, V_{GS} = -5V / 20V$		40		nC
Gate-drain charge	Q_gd	$I_{\rm D} = 40 {\rm A},$		70		
Internal gate input resistance	R _{g(int)}	$f = 1MHz$, $I_D = 0A$		2		Ω
Turn-On Switching Energy	Eon			240		
Turn-Off Switching Energy	EOFF	$V_{DS} = 800 V, V_{GS} = -5V/20V,$		80		μJ
Turn-On Delay Time	t _{d(on)}			12		ns
Rise Time	t _r	$I_D = 40A, R_{G(ext)} = 2\Omega,$ L=200µH		16		
Turn-Off Delay Time	t _{d(off)}			27		
Fall Time	t _f			7		
Avalanche Capability	E _{AS}	V _{DD} = 100V, V _{GS} =20V, L=2mH		400		mJ
Avalanche Capability	I _{AV}	V _{DD} = 100V, V _{GS} =20V, L=2mH		20		Α

Electrical Characteristics (Tc=25°C unless otherwise specified)



Reverse Diode Characteristics (T_c=25°C unless otherwise specified)

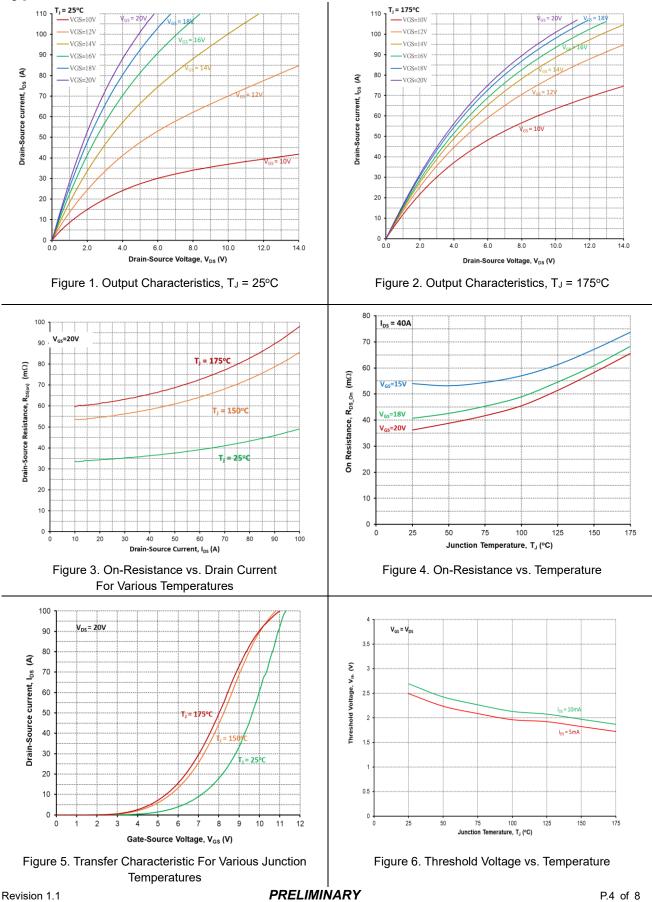
Parameter	Symbol	Condition	Min	Тур	Max	Unit
Diode Forward Voltage V		V_{GS} = -5V, I_{SD} = 20A,		3.9		
	V	V _{GS} = -5V, I _{SD} = 20A, T _J = 150°C		3.7		V
	V _{SD}	V _{GS} = -5V, I _{SD} = 20A, T _J = 175°C		3.6		
Continuous Diode Forward Current	ls	V _{GS} = -5V		60		А
Reverse Recovery time	t _{rr}			17		ns
Reverse Recovery Charge	Qrr	V_{GS} = -5V, I_{SD} = 40A,		310		nC
Peak Reverse Recovery Current	I _{rrm}	V _R = 800V, dif/dt = 4200 A/µs		30		A

Thermal Characteristics

Parameter	Symbol	Condition	Min	Тур	Max	Unit
Thermal Resistance (per device)	R _{th(j-c)}	junction-case		0.4	0.5	°C/W

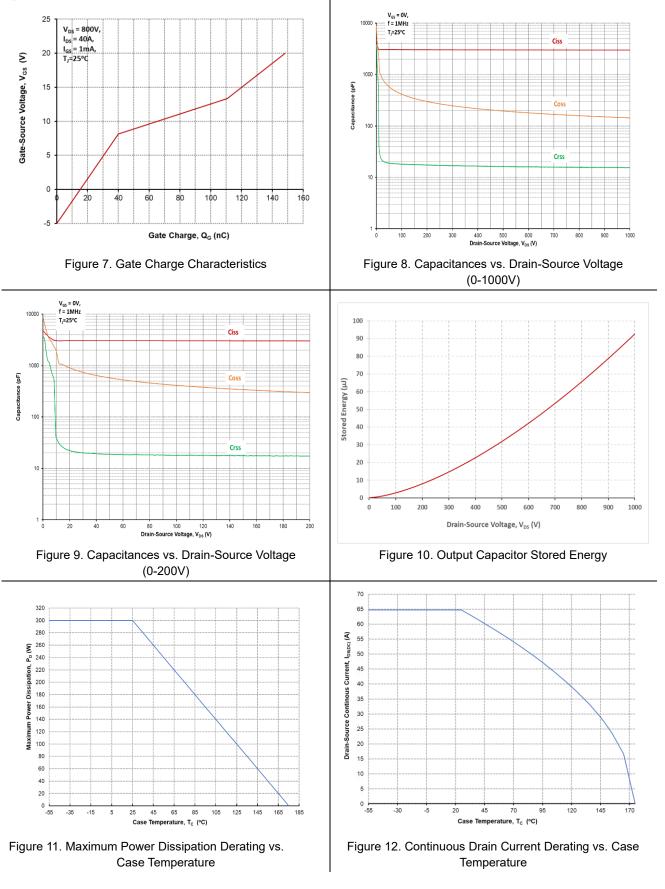


Typical Performance





Typical Performance



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Typical Performance

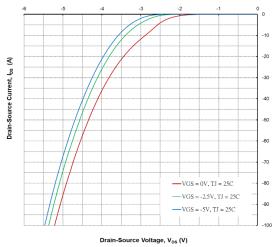
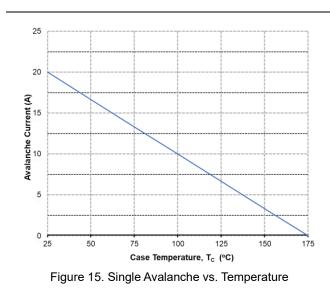


Figure 13. Body Diode Characteristics @ 25°C



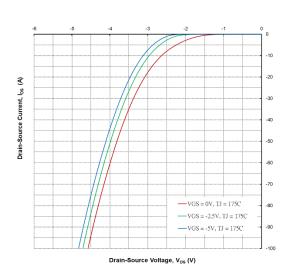


Figure 14. Body Diode Characteristics @ 175°C

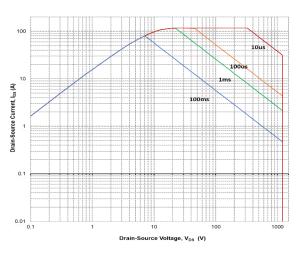
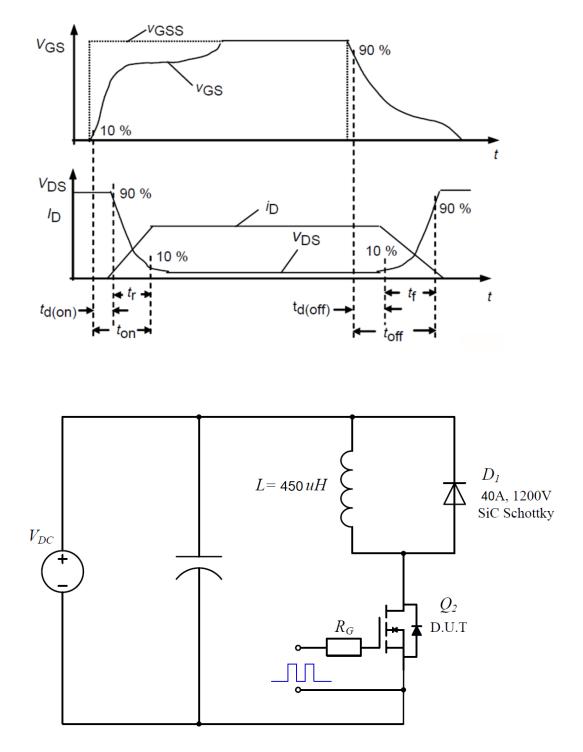


Figure 16. Safe Operating Area



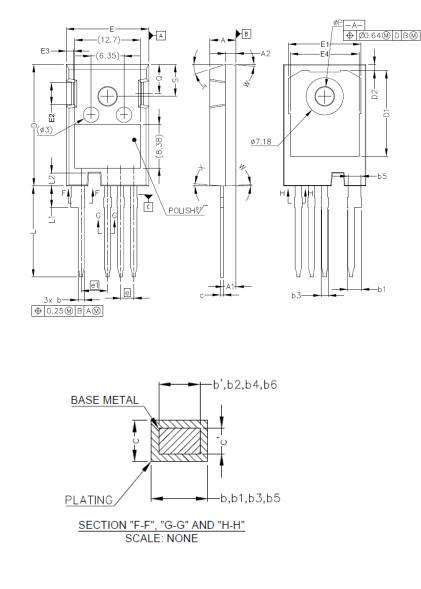
Switching Times Definition and Test Circuit





Package Dimensions

(TO-247-4 Package)



CV/MDOI	MILLIMETERS			
SYMBOL	MIN	MAX		
А	4.83	5.21		
A1	2.29	2.54		
A2	1.91	2.16		
b'	1.07	1.28		
b	1.07	1.33		
b1	2.39	2.94		
b2	2.39	2.84		
b3	1.07	1.60		
b4	1.07	1.50		
b5	2.39	2.69		
b6	2.39	2.64		
c'	0.55	0.65		
С	0.55	0.68		
D	23.30	23.60		
D1	16.25	17.65		
D2	0.95	1.25		
E	15.75	16.13		
E1	13.10	14.15		
E2	3.68	5.10		
E3	1.00	1.90		
E4	12.38	13.43		
е	2.54	BSC		
e1	5.08	BSC		
N	4	ţ		
L	17.31	17.82		
L1	3.97	4.37		
L2	2.35	2.65		
øР	3.51	3.65		
Q	5.49	6.00		
S	6.04	6.30		
Т	17.5° REF.			
W	3.5 ° REF.			
Х	4°	REF.		

NOTE ;

1. ALL METAL SURFACES: TIN PLATED, EXCEPT AREA OF CUT 2. DIMENSIONING & TOLERANCEING CONFIRM TO

ASME Y14.5M-1994.

3. ALL DIMENSIONS ARE IN MILLIMETERS. ANGLES ARE IN DEGREES.

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